

General Description

The QM0008K is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the small power switching and load switch applications.

The QM0008K meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|----------------------|--|------------|------------|
| V_{DS} | Drain-Source Voltage | 100 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D@T_A=25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^1$ | 1.2 | A |
| $I_D@T_A=70^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^1$ | 1 | A |
| I_{DM} | Pulsed Drain Current ² | 5 | A |
| $P_D@T_A=25^\circ C$ | Total Power Dissipation ³ | 1 | W |
| T_{STG} | Storage Temperature Range | -55 to 150 | $^\circ C$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^\circ C$ |

Thermal Data

| Symbol | Parameter | Typ. | Max. | Unit |
|-----------------|--|------|------|--------------|
| $R_{\theta JA}$ | Thermal Resistance Junction-ambient ¹ | --- | 125 | $^\circ C/W$ |
| $R_{\theta JC}$ | Thermal Resistance Junction-Case ¹ | --- | 80 | $^\circ C/W$ |

Product Summary

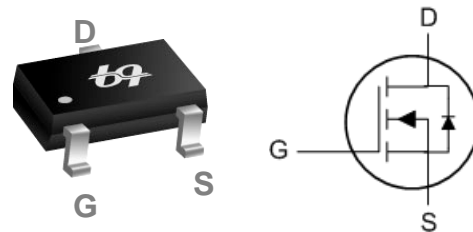


| BVDSS | RDSON | ID |
|-------|---------------|------|
| 100V | 310m Ω | 1.2A |

Applications

- High Frequency Point-of-Load Synchronous Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT23 Pin Configuration



Electrical Characteristics ($T_J=25\text{ }^\circ\text{C}$, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|------------------------------|--|---|------|-------|-----------|----------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 100 | --- | --- | V |
| $\Delta BV_{DSS}/\Delta T_J$ | BVDSS Temperature Coefficient | Reference to 25°C , $I_D=1\text{mA}$ | --- | 0.067 | --- | V/ $^\circ\text{C}$ |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance ² | $V_{GS}=10V, I_D=1A$ | --- | 260 | 310 | m Ω |
| | | $V_{GS}=4.5V, I_D=0.5A$ | --- | 270 | 320 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}, I_D=250\mu A$ | 1.0 | 1.5 | 2.5 | V |
| $\Delta V_{GS(th)}$ | $V_{GS(th)}$ Temperature Coefficient | | --- | -4.2 | --- | mV/ $^\circ\text{C}$ |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=80V, V_{GS}=0V, T_J=25^\circ\text{C}$ | --- | --- | 1 | μA |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=80V, V_{GS}=0V, T_J=25^\circ\text{C}$ | --- | --- | 5 | μA |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20V, V_{DS}=0V$ | --- | --- | ± 100 | nA |
| gfs | Forward Transconductance | $V_{DS}=5V, I_D=1A$ | --- | 2.4 | --- | S |
| R_g | Gate Resistance | $V_{DS}=0V, V_{GS}=0V, f=1\text{MHz}$ | --- | 2.8 | 5.6 | Ω |
| Q_g | Total Gate Charge (10V) | $V_{DS}=80V, V_{GS}=10V, I_D=1A$ | --- | 9.7 | 13.6 | nC |
| Q_{gs} | Gate-Source Charge | | --- | 1.6 | 2.2 | |
| Q_{gd} | Gate-Drain Charge | | --- | 1.7 | 2.4 | |
| $T_{d(on)}$ | Turn-On Delay Time | $V_{DD}=50V, V_{GS}=10V, R_G=3.3\Omega$ $I_D=1A$ | --- | 1.6 | 3.2 | ns |
| T_r | Rise Time | | --- | 19 | 34 | |
| $T_{d(off)}$ | Turn-Off Delay Time | | --- | 13.6 | 27 | |
| T_f | Fall Time | | --- | 19 | 38 | |
| C_{iss} | Input Capacitance | $V_{DS}=15V, V_{GS}=0V, f=1\text{MHz}$ | --- | 508 | 711 | pF |
| C_{oss} | Output Capacitance | | --- | 29 | 41 | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 16.4 | 23 | |

Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|--|--|------|------|------|------|
| I_S | Continuous Source Current ^{1,4} | $V_G=V_D=0V$, Force Current | --- | --- | 1.2 | A |
| I_{SM} | Pulsed Source Current ^{2,4} | | --- | --- | 5 | A |
| V_{SD} | Diode Forward Voltage ² | $V_{GS}=0V, I_S=1A, T_J=25^\circ\text{C}$ | --- | --- | 1.2 | V |
| t_{rr} | Reverse Recovery Time | $I_F=1A, di/dt=100A/\mu s, T_J=25^\circ\text{C}$ | --- | 14 | --- | nS |
| Q_{rr} | Reverse Recovery Charge | | --- | 9.3 | --- | nC |

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3.The power dissipation is limited by 150°C junction temperature
- 4.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

N-Ch 100V Fast Switching MOSFETs

Typical Characteristics

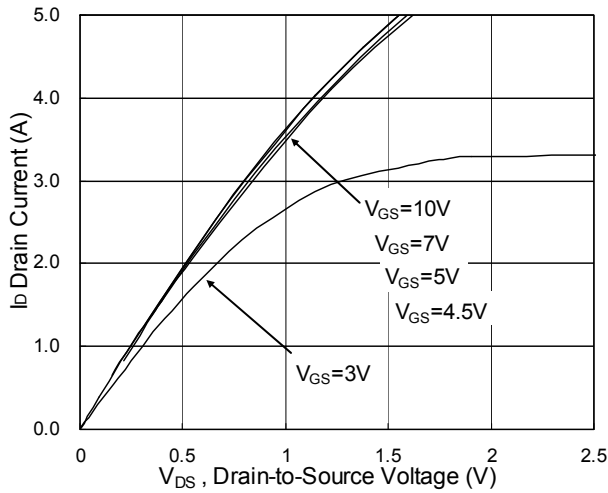


Fig.1 Typical Output Characteristics

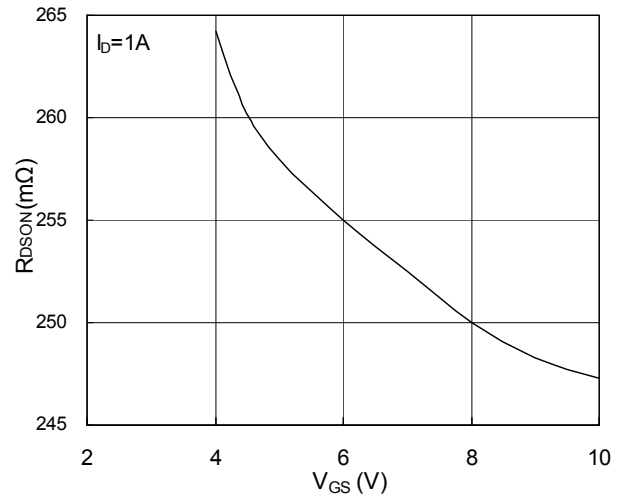


Fig.2 On-Resistance vs. Gate-Source

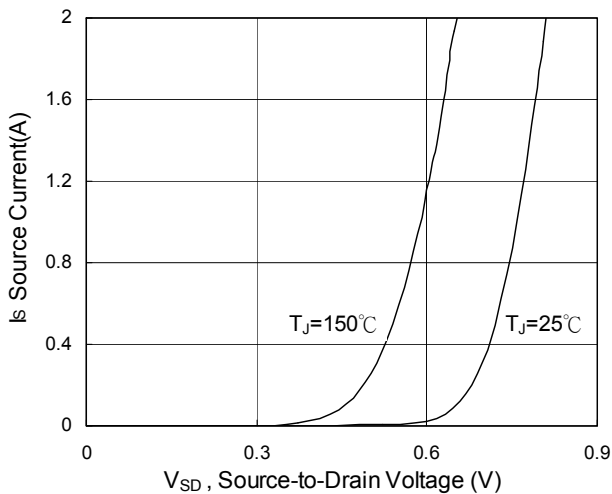


Fig.3 Forward Characteristics of Reverse

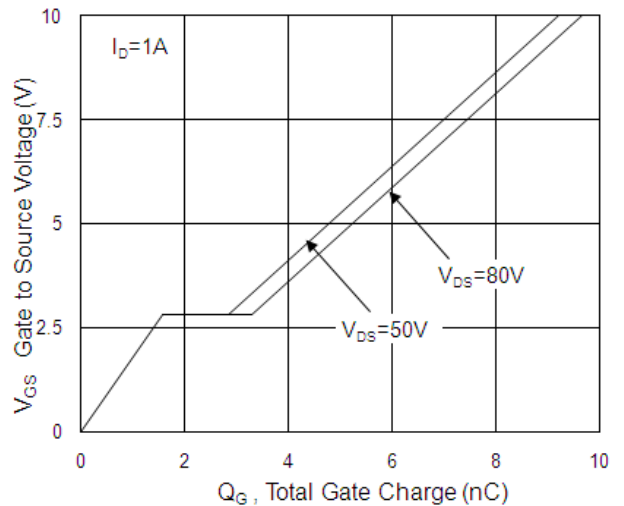


Fig.4 Gate-Charge Characteristics

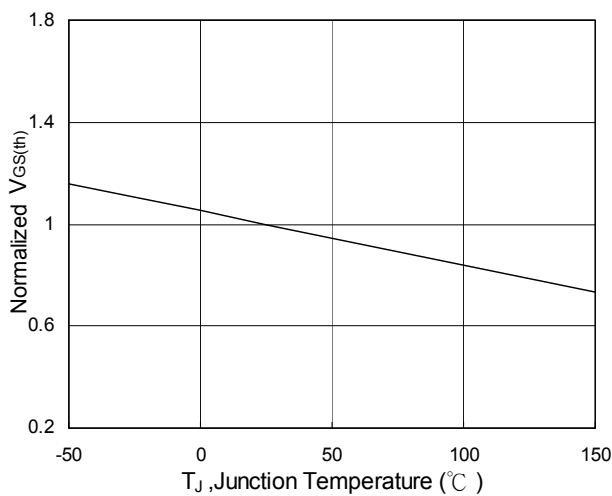


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

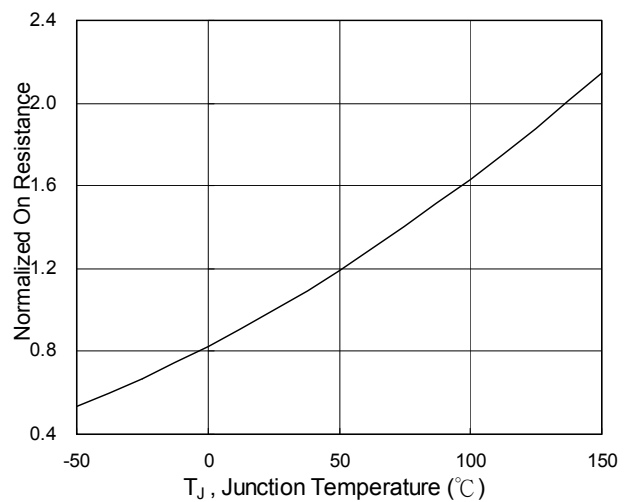


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

N-Ch 100V Fast Switching MOSFETs

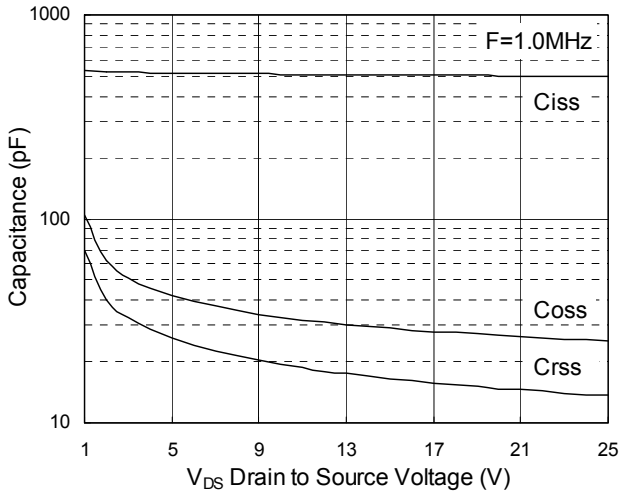


Fig.7 Capacitance

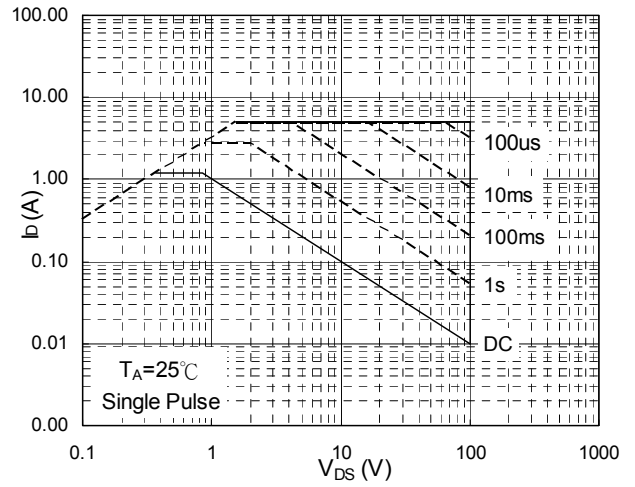


Fig.8 Safe Operating Area

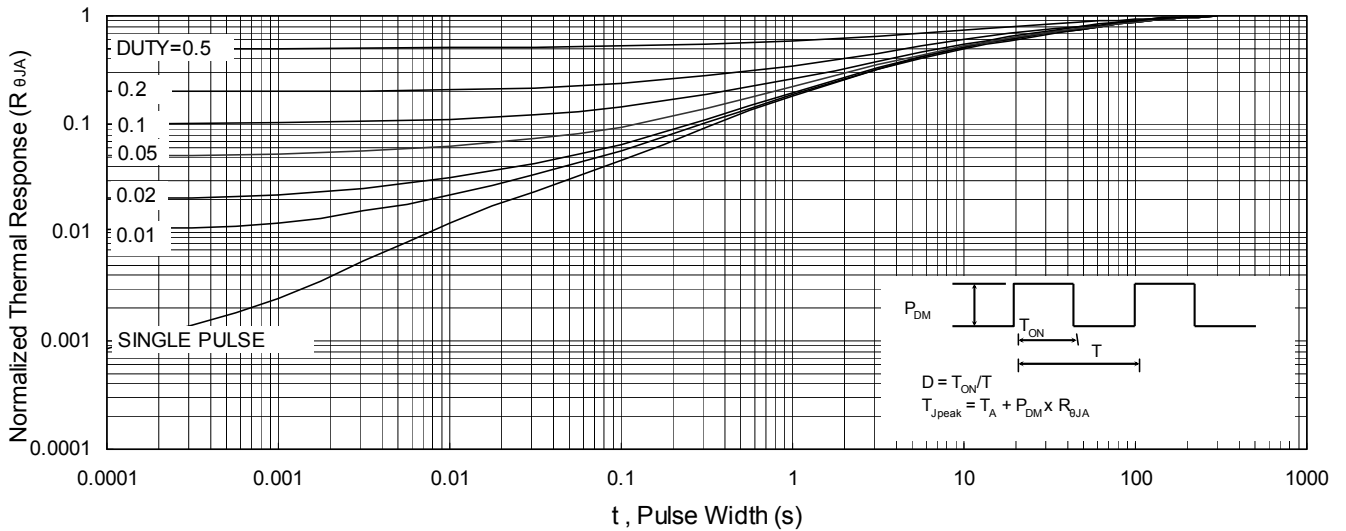


Fig.9 Normalized Maximum Transient Thermal Impedance

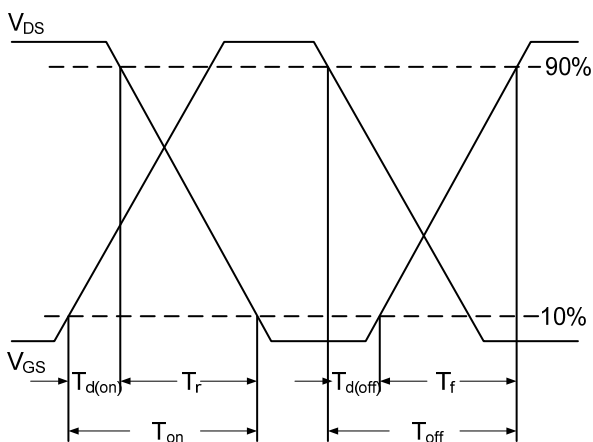


Fig.10 Switching Time Waveform

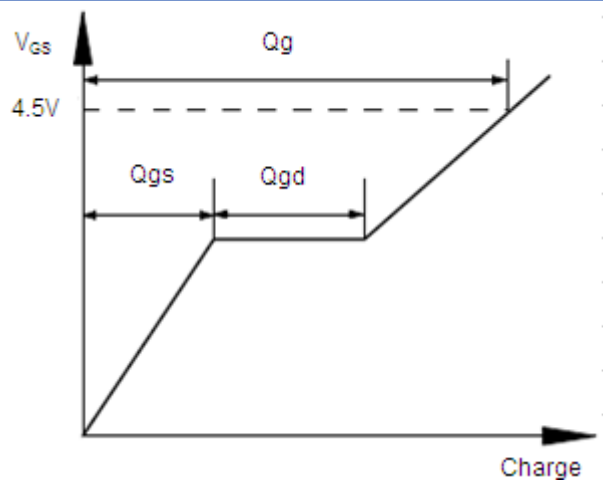


Fig.11 Gate Charge Waveform